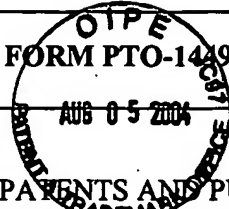


Page 1 of 1		Atty. Docket No.: H0003798(1100.1204101)	Serial No.: 10/718,168
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT		Applicant: Peter F. Symosek et al.	
		Filing Date: November 20, 2003	Group Art: 2133

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Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
KK	2001/005863 A1	06/2001	Schreier et al.			
KK	5,884,226	03/1999	Anderson et al.			

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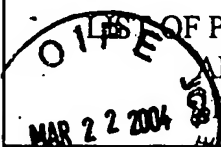
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KK	03054824 A	07/2003	WO	

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KK	Griffin et al., "Characterization of gaseous effluents from modeling of LWIR hyperspectral measurements," Proceedings of the SPIE - The International Society for Optical Engineering, vo. 4381, pp. 360-369, 2001.
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449		Atty. Docket No.: H0003798(1100.1204101)	Serial No.: 10/718,168
Page 1 of 1			
		Applicant: Peter F. Symosek et al.	
		Filing Date: November 20, 2003	Group Art: unknown

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KK	Polak, M.L., et al., "Passive Fourier-transform infrared spectroscopy of chemical plumes: an algorithm for quantitative interpretation and real-time background removal," Applied Optics, Vol. 34, No. 24, pp. 5406-5412, August 20, 1995.

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